

<b>Notice of References Cited</b>	Application/Control No. 10/694,798	Applicant(s)/Patent Under Reexamination: WU ET AL.	
	Examiner David Buttner	Art Unit 1712	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,248,028	06-2001	Higuchi et al.	473/374
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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